

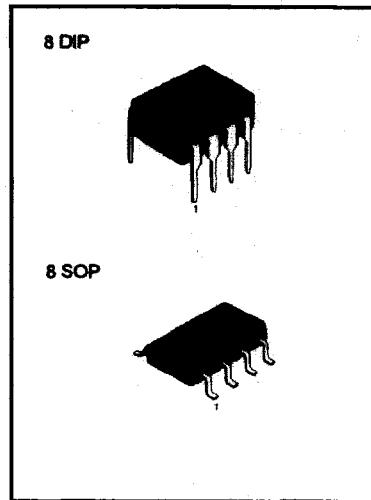
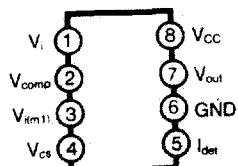
POWER FACTOR CONTROLLER

The KA7524B provides the necessary features to implement the Electronic BALLAST control and S.M.P.S application for designing on active power factor correction circuit.

FEATURES

- Internal self-starting
- Micro power start up mode
- Included under voltage lockout circuit
- Internal 1% reference
- High output current : Peak 500mA

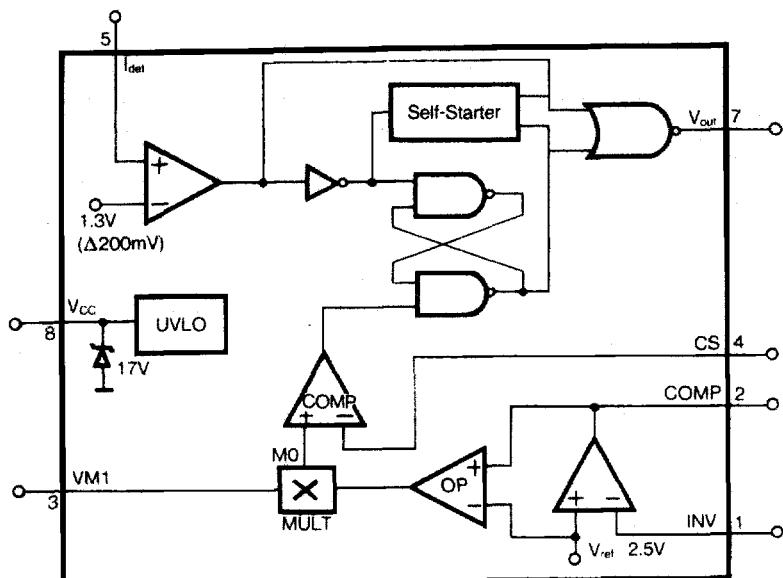
CONNECTION DIAGRAM KA7524/KA7524D (8 DIP, 8 SOP)



ORDERING INFORMATION

Device	Ref. Voltage	Package	Operating Temperature
KA7524B	1%	8 DIP	-25 ~ +100°C
KA7524BD	1%	8 SOP	

BLOCK DIAGRAM



ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	Value	Unit
Supply Voltage	V _{CC}	20	V
Peak driver output current	I _{O(P)}	500	mA
Detect clamping diode current	I _{DET}	10	mA
Output clamping diode current	I _{O(C,D)}	10	mA
Operating ambient temperature	T _{OPR}	-25 ~ + 100	°C
Storage Temperature	T _{STG}	-65 ~ + 150	°C

ELECTRICAL CHARACTERISTICS

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Under Voltage Lockout Section						
Start Threshold Voltage	V _{TH(ST)}		9.2	10	10.8	V
UV Lockout Hysteresis	V _{THS}		1.8	2.0	2.2	V
Supply Zener Voltage	V _Z			17		V
Supply Current Section						
Start-Up Supply Current	I _{START}	V _{CC} < V _{TH}		0.25	0.5	mA
Operating Supply Current	I _{CC}	V _{CC} = 12V, No Load		6	12	mA
Dynamic Operating Current	I _{CC(D)}	V _{CC} = 12V, f = 50KHz, C _{as} = 1000PF		10	20	mA
Reference Section (Note1)						
Reference Voltage	V _{REF}	KA7524B/BD	2.475	2.5	2.525	V
Line regulation	V _{REF}	12V < V _{CC} < 16V		0.1	10	mV
Load Regulation	V _{REF}	0 < I _{REF} < 2mA		0.1	10	mV
Temperature Stability	ST _T			20		mV
Error Amplifier Section						
Input Offset Voltage	V _{IO}		-15		15	mV
Input Bias Current	I _{BIAS}		-1	-0.1	1	uA
Large Signal Open Loop Gain	G _V		60	100		dB
Power Supply Rejection Ratio	PSRR		60	86		dB
Output Current	I _{SOURCE}		2			mA
	I _{SINK}				-2	mA
Output Voltage Range	V _{O(P)}		1.2		4	V
Unity Gain Bandwidth	UBW			1.0		MHz
Phase Margin	MPH			57		°C

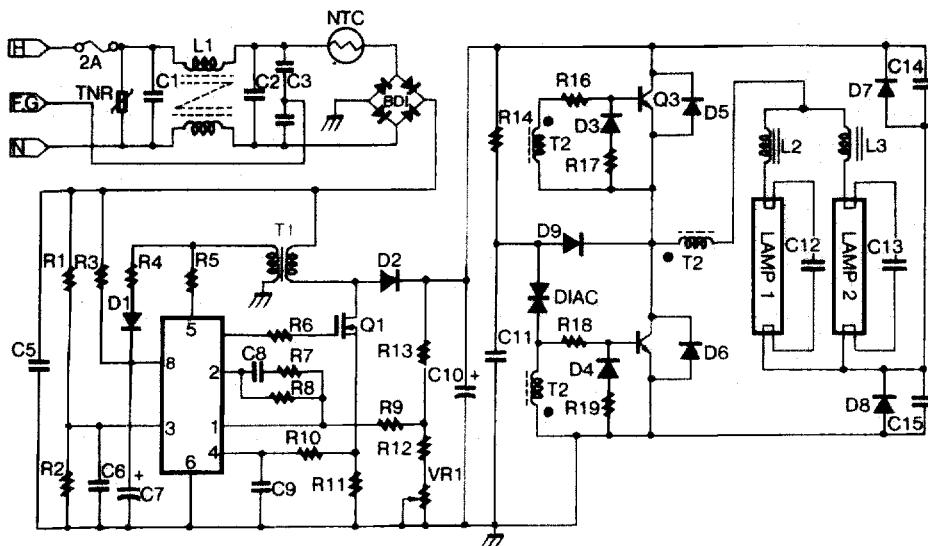
ELECTRICAL CHARACTERISTICS(Continue)

Characteristic	Symbol	Test Conditions	Min	Typ	Max	Unit
Multiplier Section						
M1 Input Voltage Range	$V_{I(M1)}$		0		2	V
M2 Input Voltage Range	$V_{I(M2)}$		V_{REF}		V_{REF+1}	V
Input Bias Current	I_{BIAS}		-2	-0.5	2	uA
Multiplier Gain (Note2)	G_V	$V_{I(M1)} = 0.5V, V_{I(M2)} = 3V$		0.8		uA
Multiplier Gain Stability	ST_T			-0.2		%/C
Current Sense Section						
Input Offset Voltage	V_{IO}		-10		10	mV
Input Bias Current	I_{BIAS}	$0V < V_{CS} < 1.7V$	-5		5	uA
C. Sense Delay to Output	$t_{D(S)}$	Error Amp Output = 3.7V		200	500	nS
Current Detect Section						
Input Voltage Threshold	V_{TH}		1.0	1.3	1.6	V
Hysteresis	V_{THS}			200		mV
Input Low Clamp Voltage	$V_{IC(L)}$	$I_{DET} = 0mA$			0.95	V
Input High Clamp Voltage	$V_{IC(H)}$	$I_{DET} = 3mA$	6.1	7.1		V
Input Current	I_J	$0.9 < V_{DET} < 6V$		5		uA
Input Clamp Diode Current	I_{CD}	$V_{DET} < 0.9V, V_{DET} > 6V$			3	mA
Current Detect Section						
Output Voltage(High)	V_{OPH}	$I_O = -10mA, V_{CC} = 12V$	7	9		V
Output Voltage(Low)	V_{OLL}	$I_O = 10mA, V_{CC} = 12V$		0.8	1.8	V
Rising Time	t_R	$CL = 1000pF$		100	200	nS
Falling Time	t_F	$CL = 1000pF$		90	200	nS
Self-Starting Section						
Self-Starting Time	t_{SS}		12			uS

Note 1. Reference can not be tested on the PKG

2. $G_V = V_{OPH} / (V_{I(M1)} * V_{I(M2)} - V_{REF})$

KA7524B APPLICATION CIRCUIT



PART LIST

Resistor	Capacitor	Semiconductor
R1	0.1 μ F	IC1 KA7524B
R2	0.1 μ F	Q1 IRF830
R3	4700pF	Q2 KSC5039
R4	4700pF	Q3 KSC5039
R5	0.1 μ F	D1 1N4004
R6	0.01 μ F	D2 1N4937
R7	100 μ F	D3 1N4148
R8	0.1 μ F	D4 1N4148
R9	3300pF	D5 FR107
R10	47 μ F/450V	D6 FR107
R11	0.1 μ F	D7 FR107
R12	3300pF	D8 FR107
R13	3300pF	BD1 PBP204
R14	0.01 μ F	TNR 12G471
R15	0.01 μ F	DIAIC 32V
R16		
R17		
R18		
R19		
VR1		
NTC		
Magnetics		
T1 EI-25 (PC30): P = 70T, S = 4T, Gap = 0.5mm		
T2 D15 (GP-5): P = 3T, S = 13T		
L1 EE-25 (Iron Power) 80mH		
L2, L3 EI-25 (PC30): 150T, Gap = 0.4mm		